

<b>Notice of References Cited</b>	Application/Control No. 10/519,584	Applicant(s)/Patent Under Reexamination FUJII ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2003/0082088 A1	05-2003	Barelko et al.	423/327.1
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**NON-PATENT DOCUMENTS**

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